

Abstract Submitted  
for the MAR15 Meeting of  
The American Physical Society

**Growth, transfer, structural, optical, and electrical properties  
of large-size transition-metal dichalcogenide monolayer single-crystals<sup>1</sup>**

ZHENG YANG, BO HSU, JIAO XIAO, GEORGE POULOS, Univ of Illinois - Chicago, YANG RESEARCH GROUP TEAM — We report growth, transfer process, as well as structural, optical, and electrical properties of large-size and high-quality two-dimensional transition-metal dichalcogenide MX<sub>2</sub> (M=Mo, W; X=S, Se) single-crystalline triangular-shape nanosheets composed of one to a few monolayers. A vapor-trapping enhanced chemical vapor deposition approach was employed for the MX<sub>2</sub> monolayer single crystal growth. The number of layers, crystallinity, and uniformity of the as-grown MX<sub>2</sub> were characterized and confirmed by Raman and photoluminescence measurements. The MX<sub>2</sub> monolayer single-crystal triangles show comparable size and uniformity to the state-of-the-art results reported as of now. The optical properties of the MX<sub>2</sub> were studied based on the analysis of the photoluminescence results. The electrical properties including resistivity, mobility, carrier type and concentration, and contact resistance of the MX<sub>2</sub> were characterized by both three-terminal field-effect transistor and Hall effect transport measurements. The Hall bar devices were fabricated by lithography and dry-etching of the as-grown single-crystalline MX<sub>2</sub>. The transfer process of the MX<sub>2</sub> from growth substrate (SiO<sub>2</sub>-on-Si) to various substrates was successfully demonstrated.

<sup>1</sup>Acknowledgement to the funding support from Ignite Award.

Zheng Yang  
Univ of Illinois - Chicago

Date submitted: 14 Nov 2014

Electronic form version 1.4